

# SiC Schottky Diode

Ultra fast switching Zero reverse recovery

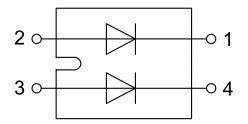
Part number DCG85X1200NA

## prelimininary $V_{RRM} = 1200 V$ $I_{FAV} = 2x 41 A$



Backside: isolated

**UL** pending



#### Features / Advantages:

- · Ultra fast switching
- · Zero reverse recovery
- Zero forward recovery
- Temperature independent switching behavior
- · Positive temperature coefficient of forward voltage
- Tvjm = 175°C

### **Applications:**

- Solar inverter
- Uninterruptible power supply (UPS)
- Welding equipment
- Switched-mode power supplies
- Medical equipment
- High speed rectifier

### Package: SOT-227B (minibloc)

- Isolation Voltage: 3000 V~
- Industry standard outline
- RoHS compliant
- Epoxy meets UL 94V-0
- Base plate with Aluminium nitride isolation for low thermal resistance
- Advanced power cycling

#### Terms & Conditions of Usage

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application- and assembly notes must be considered as an assurance of component characteristics. dered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact the sales office, which is responsible for you. Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact the sales office, which is responsible for you. Should you intend to use the product in aviation, in health or live endangering or life support applications, please notify. For any such application we urgently recommend to perform joint risk and guality assessments:

- the conclusion of quality agreements;
- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.

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## prelimininary

SiC Diod	SiC Diode (per leg)			Ratings		
Symbol	Definitions	Conditions	min.	typ.	max.	
V <sub>RSM</sub>	max. non-repetitive reverse blocking voltage	$T_{vJ} = 25^{\circ}C$			1200	V
V <sub>RRM</sub>	max. repetitive reverse blocking voltage	$T_{vJ} = 25^{\circ}C$			1200	V
I <sub>R</sub>	reverse current	$V_{R} = V_{RRM} \qquad \qquad T_{VJ} = 25^{\circ}C \\ T_{VJ} = 175^{\circ}C$		70 130	400 800	μA μA
V <sub>F</sub>	forward voltage	$I_F = 20 \text{ A}$ $T_{VJ} = 25^{\circ}\text{C}$ $I_F = 40 \text{ A}$		1.5	1.8	V V
		$I_F = 20 \text{ A}$ $T_{VJ} = 175^{\circ}\text{C}$ $I_F = 40 \text{ A}$		2.20	3.0	V V
I <sub>FAV</sub>	average forward current	$ \begin{array}{ccc} T_{c} = & 80^{\circ}C \\ T_{c} = & 100^{\circ}C \end{array} \end{array} rectangular, d = 0.5 \\ T_{vJ} = & 175^{\circ}C \end{array} $			41 36	A A
I <sub>F25</sub> I <sub>F80</sub> I <sub>F100</sub>	forward current	based on typ. $V_{F0}$ and $r_F$ $\begin{array}{ccc} T_C = & 25^\circ C \\ T_C = & 80^\circ C \\ T_C = & 100^\circ C \end{array}$			73 56 49	A A A
I <sub>FSM</sub>	max forward surge current	t = 10 ms,half sine (50 Hz) $t_p = 10 \ \mu$ s, pulse $T_{VJ} = 25^{\circ}C$ $V_R = 0V$			1150	A A
V <sub>F0</sub> r <sub>F</sub>	threshold voltage slope resistance	$\left. \begin{array}{c} T_{VJ} = & 125^{\circ}C \\ for \ power \ loss \ calculation \end{array} \right. \left. \begin{array}{c} T_{VJ} = & 125^{\circ}C \\ & 175^{\circ}C \\ T_{VJ} = & 125^{\circ}C \\ & 175^{\circ}C \end{array} \right.$		0.80 0.73 28.4 35.2		V V mΩ mΩ
Qc	total capacitive charge			200		nC
С	total capacitance	$\left. \begin{array}{c} V_{_{R}} = 0 \ V \\ V_{_{R}} = 400 \ V \\ V_{_{R}} = 800 \ V \end{array} \right\} \hspace{1.5cm} T_{_{VJ}} = 25^{\circ}C, \ f = 1 \ MHz$		3000 185 135		pF pF pF
R <sub>thJC</sub> R <sub>thJH</sub>	thermal resistance junction to case thermal resistance junction to heatsink	with heatsink compound; IXYS test setup		0.72	0.60	K/W K/W



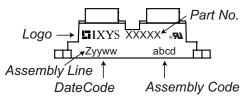
### prelimininary

Package	Outlines SOT-227B (minibloc)		Ratings				
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
IRMS	RMS current	per terminal				100	A
T <sub>stg</sub>	storage temperature			-40		150	°C
T <sub>op</sub>	operation temperature			-40		150	°C
T <sub>vJ</sub>	virtual junction temperature			-40		175	°C
Weight					30		g
Mp	mounting torque <sup>1)</sup>	screws to heats	sink			1.5	Nm
		terminal connec	ction screws			1.3	Nm
d <sub>spp</sub>			terminal to terminal	10.5			mm
d <sub>Spb</sub>	creepage distance on surface		terminal to backside	8.5			mm
d <sub>App</sub>			terminal to terminal	3.2			mm
d <sub>Apb</sub>	striking distance through air		terminal to backside	6.8			mm
VISOL	isolation voltage	t = 1 second	50 / 60 Hz, RMS; I <sub>ISOL</sub> ≤ 1 mA	3000			V
		t = 1 minute	$50700$ Hz, $\pi$ WIS, $I_{ISOL} \leq 1$ HIA	2500			V
C <sub>P</sub>	coupling capacity per switch	between shorted te lization	erminals of diodes and back side metal-				pF

<sup>1)</sup> further information see application note IXAN0073 on

www.ixys.com/TechnicalSupport/appnotes.aspx (General / Isolation, Mounting, Soldering, Cooling)





#### Part description

- D = Diode

- D = Diode C = SiC G = extreme fast 85 = Current Rating [A] X = Parallel legs 1200 = Reverse Voltage [V] NA = SOT-227 (minibloc)

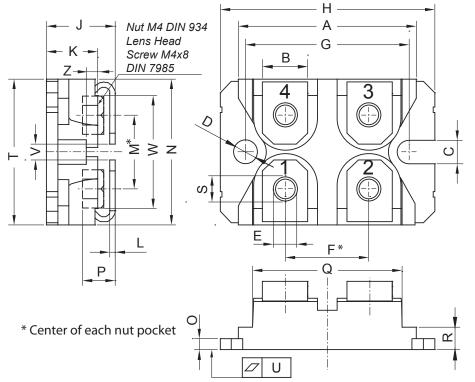
Orderin	9	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standar	ł	DCG85X1200NA	DCG85X1200NA	Tube	10	520214

Equiva	lent Circuits for Simulation	*on die level, typical				
	)[R₀]-	$T_{vJ} = 125^{\circ}C$	T <sub>vJ</sub> = 175°C	·         		
V <sub>0 max</sub>	threshold voltage	0.80	0.73	V		
$\mathbf{R}_{0 \max}$	slope resistance *	28.4	35.2	mΩ		

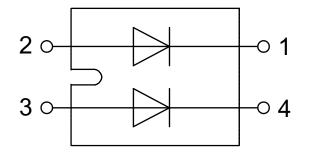


prelimininary

### **Outlines SOT-227B (minibloc)**



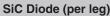
Dim	Millimeter		Inches		
Dim.	min	max	min	max	
Α	31.50	31.88	1.240	1.255	
В	7.80	8.20	0.307	0.323	
С	4.09	4.29	0.161	0.169	
D	4.09	4.29	0.161	0.169	
Е	4.09	4.29	0.161	0.169	
F	14.91	15.11	0.587	0.595	
G	30.12	30.30	1.186	1.193	
Н	37.80	38.23	1.488	1.505	
J	11.68	12.22	0.460	0.481	
K	8.92	9.60	0.351	0.378	
L	0.74	0.84	0.029	0.033	
Μ	12.50	13.10	0.492	0.516	
Ν	25.15	25.42	0.990	1.001	
0	1.95	2.13	0.077	0.084	
Р	4.95	6.20	0.195	0.244	
Q	26.54	26.90	1.045	1.059	
R	3.94	4.42	0.155	0.167	
S	4.55	4.85	0.179	0.191	
Т	24.59	25.25	0.968	0.994	
U	-0.05	0.10	-0.002	0.004	
V	3.20	5.50	0.126	0.217	
W	19.81	21.08	0.780	0.830	
Ζ	2.50	2.70	0.098	0.106	



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## prelimininary



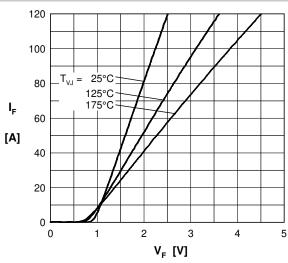
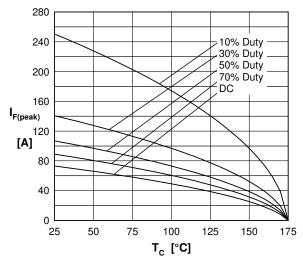
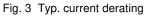
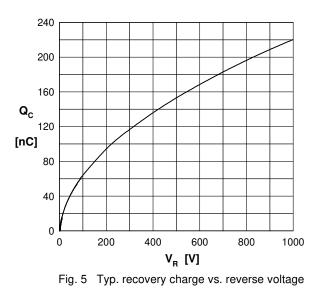


Fig. 1 Typ. forward characteristics







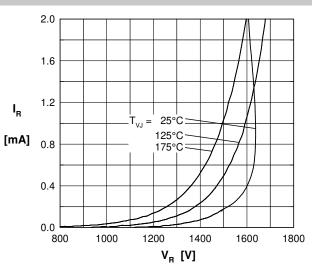
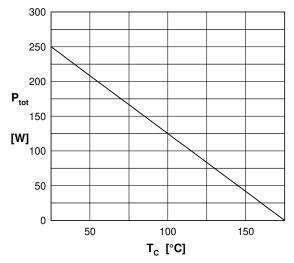
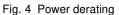
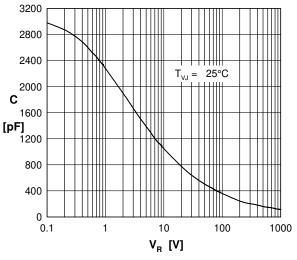
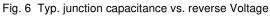


Fig. 2 Typ. reverse characteristics









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## prelimininary

### SiC Diode (per leg)

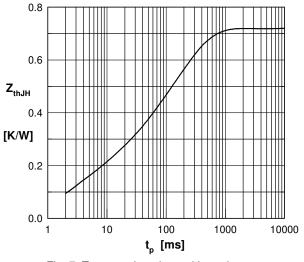


Fig. 7 Typ. transient thermal impedance

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